

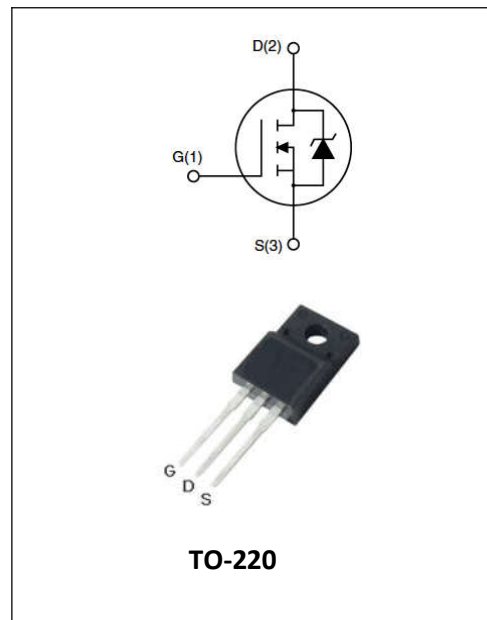
Silicon N-Channel MOSFET

Features

- ① $V_{DS}=650V$, $I_D=8A$
- ② $R_{DS(ON)} = 1.4\Omega$ (Max.) @ $V_{GS} = 10V$, $I_D = 4A$
- ③ Fast switching
- ④ 100% avalanche tested
- ⑤ Improved dv/dt capability
- ⑥ RoHS and Halogen-Free Compliant

Application

- ① Switch Mode Power Supply (SMPS)
- ② Uninterruptible Power Supply (UPS)
- ③ Power Factor Correction (PFC)



Absolute Maximum Ratings $T_C=25^\circ C$ unless otherwise specified

Symbol	Parameter		Max.	Units
V_{DSS}	Drain-Source Voltage		650	V
V_{GSS}	Gate-Source Voltage		± 30	V
I_D	Continuous Drain Current note5	$T_C = 25^\circ C$	8	A
I_{DM}	Pulsed Drain Current note3		32	A
P_D	Power Dissipation note2	$T_C = 25^\circ C$	35	W
E_{AS}	Single Pulse Avalanche Energy note3.6		281	mJ
$R_{\theta JC}$	Thermal Resistance, Junction to Case		3.6	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient note1,4		62.5	$^\circ C/W$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ C$

Electrical Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
Off Characteristic						
B _{VDSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250μA	650	-	-	V
I _{DSS}	Drain-Source Leakage Current	V _{DS} = 650V, V _{GS} = 0V	-	-	1	μA
I _{GSS}	Gate to Body Leakage Current	V _{DS} = 0V, V _{GS} = ±30V	-	-	±100	nA
On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	2	-	4	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 4A	-	1.17	1.4	Ω
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 25V, V _{GS} = 0V, f = 1.0MHz	-	870	-	pF
C _{oss}	Output Capacitance		-	97	-	pF
C _{rss}	Reverse Transfer Capacitance		-	9.6	-	pF
Switching Characteristics						
Q _g	Total Gate Charge	V _{DS} = 520V, I _D = 8A, V _{GS} = 10V	-	22	-	nC
Q _{gs}	Gate-Source Charge		-	5	-	
Q _{gd}	Gate-Drain(“Miller”) Charge		-	5.5	-	
t _{d(on)}	Turn-On Delay Time	V _{DS} = 100V, I _D = 8A, R _G = 25Ω, V _{GS} =10V	-	12	-	ns
t _r	Turn-On Rise Time		-	20	-	
t _{d(off)}	Turn-Off Delay Time		-	74	-	
t _f	Turn-Off Fall Time		-	33	-	
Diode Characteristics						
V _{DS}	Diode Forward Voltage note3	I _S =8A . V _{GS} = 0V	-	-	1.4	V
t _{rr}	Reverse Recovery Time	I _{SD} =8A, V _{GS} = 0V dl _{SD} /dt=100A/μs	-	506	-	ns
Q _{rr}	Reverse Recovery Charge		-	2.7	-	nC

Notes:

- 1.The value of $R_{\theta JC}$ is measured in a still air environment with $T_A = 25^{\circ}\text{C}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.
- 2.The power dissipation PD is based on $T_{J(MAX)} = 150^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 3.Single pulse width limited by junction temperature $T_{J(MAX)} = 150^{\circ}\text{C}$.
- 4.The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
- 5.The maximum current rating is package limited.
- 6.The EAS data shows Max. rating. The test condition is $V_{DS} = 50V, V_{GS} = 10V, L = 10mH$

Typical Performance Characteristics

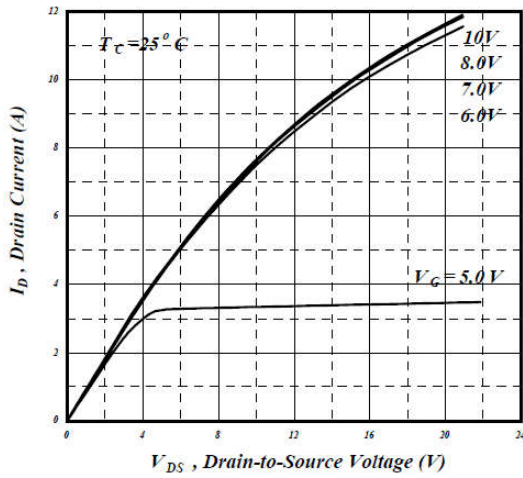


Figure 1. Output Characteristics

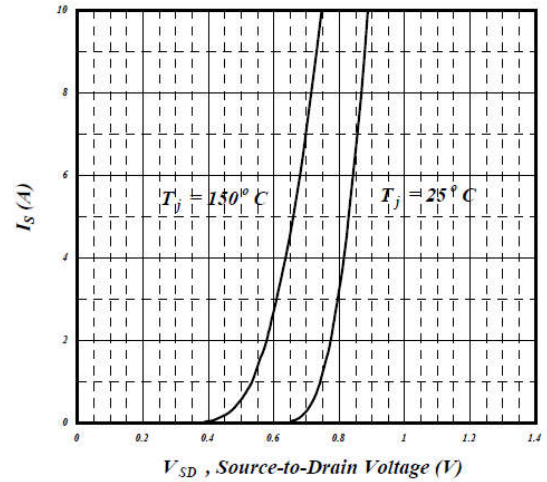


Figure 2. Body Diode Forward Voltage vs Source Current and Temperature

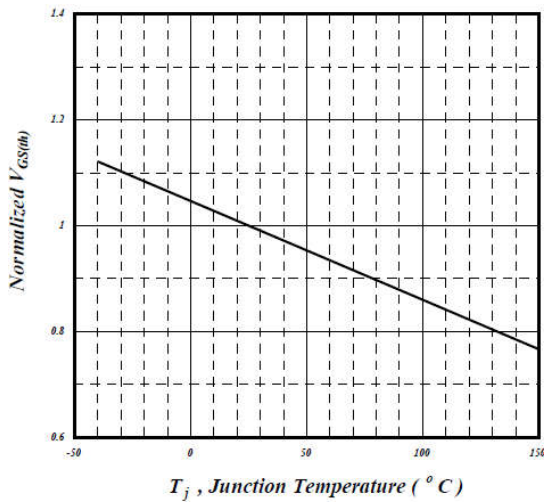


Figure 3. Normalized On Resistance vs Junction Temperature

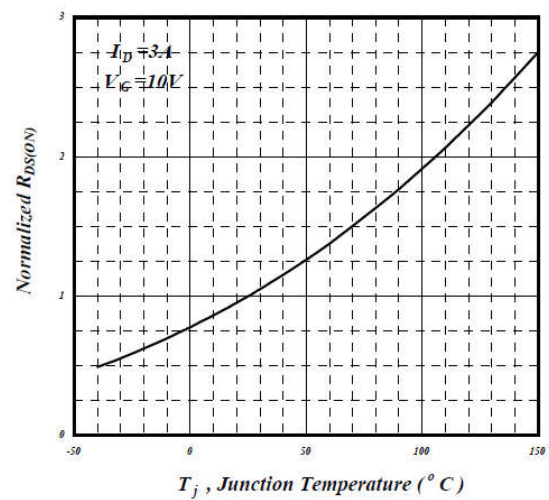


Figure 4. Normalized On Resistance vs Junction Temperature

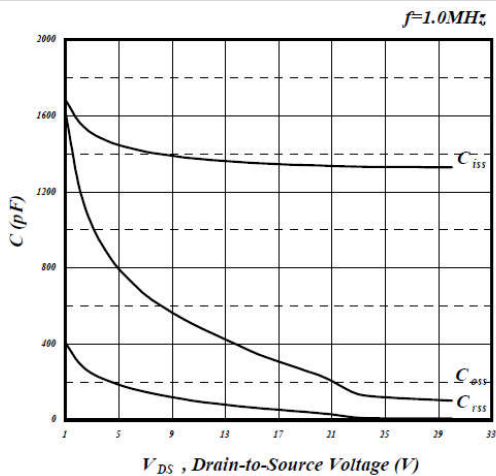


Figure 5. Capacitance Characteristics

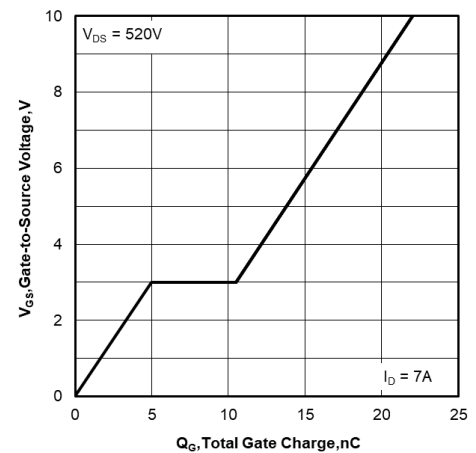


Figure 6. Gate Charge Characteristics

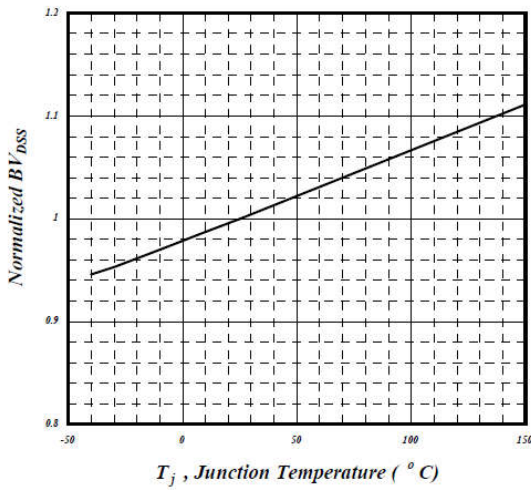


Figure 7. Normalized Breakdown Voltage vs Junction Temperature

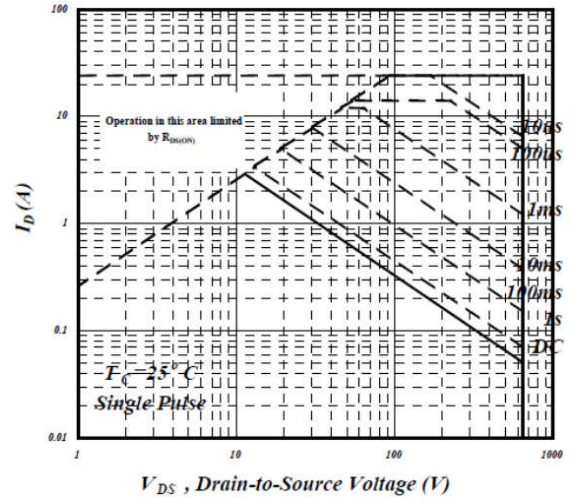


Figure 8. Maximum Safe Operating Area

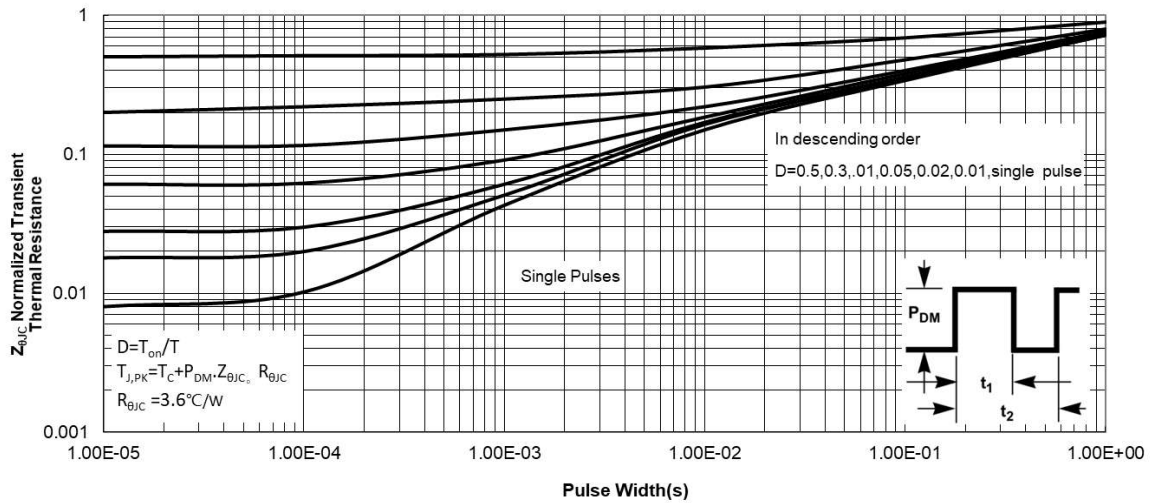
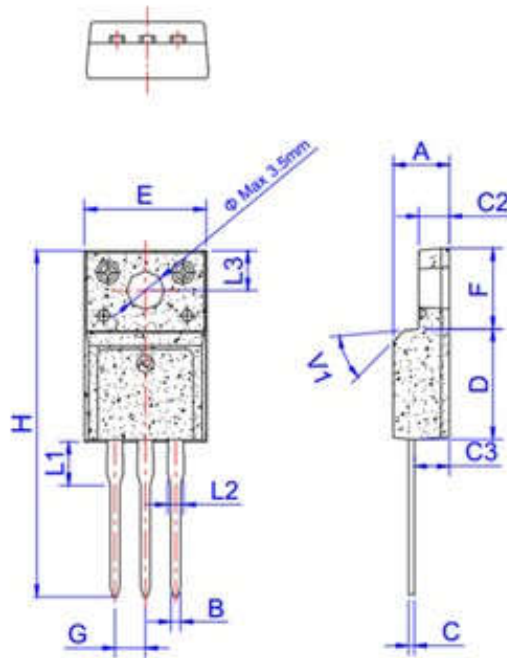


Figure 9. Maximum Effective Transient Thermal Impedance, Junction-to-Case

TO-220F Package Mechanical Data



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	4.50		4.90	0.177		0.193
B	0.74	0.80	0.83	0.029	0.031	0.033
C	0.47		0.65	0.019		0.026
C2	2.45		2.75	0.096		0.108
C3	2.60		3.00	0.102		0.118
D	8.80		9.30	0.346		0.366
E	9.80		10.4	0.386		0.410
F	6.40		6.80	0.252		0.268
G		2.54			0.1	
H	28.0		29.8	1.102		1.173
L1		3.63			0.143	
L2	1.14		1.70	0.045		0.067
L3		3.30			0.130	
V1		45°			45°	



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MPF8N65

NOTE:

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.
2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
3. MOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. Shenzhen Minos reserves the right to make changes in this specification sheet and is subject to change without prior notice.

CONTACT:

深圳市迈诺斯科技有限公司（总部）

地址：深圳市福田区华富街道田面社区深南中路4026号田面城市大厦22B-22C

邮编：518025

电话：0755-83273777